



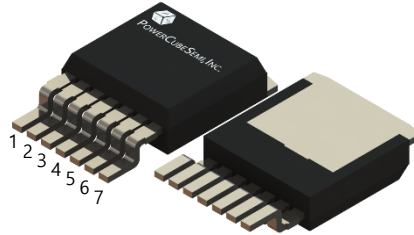
PCMQ050R065D7Y

650V 57A 50mΩ Silicon Carbide MOSFET

Features

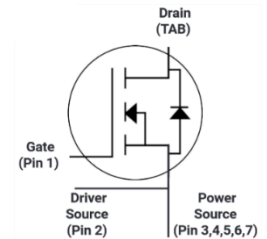
- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free, RoHS compliant
- AEC-Q101 qualified

Package Outline



Applications

- Power Factor Correction (PFC)
- Solar Inverters
- Uninterruptible power supply
- Motor Drives
- Photovoltaic inverter
- Electric car
- EV Charging System
- On-Board Charger (OBC)



Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Value	Units
V_{DSS}	Drain-Source Voltage	650	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$) - Continuous ($T_C = 110^\circ\text{C}$)	57	A
		38	A
I_{DM}	Drain Current - Pulsed	127	A
$V_{GS, max}$	Gate-Source Voltage (AC $f > 1\text{Hz}$, duty cycle $< 1\%$)	-10 / +25	V
$V_{GS, op}$	Gate-Source Voltage	-5 / +20	V
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	223	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +175	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1.6 mm from case for 10 seconds	260	$^\circ\text{C}$
E_{AS}	Avalanche energy, Single Pulse ($V_{DD}=100\text{V}$, $I_D=10\text{A}$)	1600	mJ

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.67	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	-	$^\circ\text{C/W}$

Electrical Characteristics

$T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	650	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 650\text{ V}, V_{GS} = 0\text{ V}$	--	<1	50	μA
I_{GSS}	Gate-Body Leakage Current	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$	--	--	250	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 20\text{ mA}$	--	2.6	--	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 20\text{ V}, I_D = 20\text{ A}$	--	50	65	m Ω
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$	--	1850	--	pF
C_{oss}	Output Capacitance		--	208	--	pF
C_{rss}	Reverse Transfer Capacitance		--	33	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 400\text{ V}, V_{GS} = -4 / 20\text{ V},$ $I_D = 20\text{ A},$ $R_L = 20\text{ }\Omega, R_G = 2.7\text{ }\Omega$	--	16	--	ns
t_r	Turn-On Rise Time		--	17	--	
$t_{d(off)}$	Turn-Off Delay Time		--	20	--	
t_f	Turn-Off Fall Time		--	10	--	
E_{on}	Turn-On Switching loss	$V_{DD} = 400\text{ V}, V_{GS} = 0 / 20\text{ V}$ $R_G = 2.7\text{ }\Omega$	--	21	--	μJ
E_{off}	Turn-Off Switching loss		--	28	--	
Q_g	Total Gate Charge	$V_{DS} = 400\text{ V}, I_D = 30\text{ A},$ $V_{GS} = -5 / 20\text{ V}$	--	121	--	nC
Q_{gs}	Gate-Source Charge		--	30	--	
Q_{gd}	Gate-Drain Charge		--	43	--	
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	39	--	A
V_{SD}	Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 5\text{ A}$	--	3.0	--	V
t_{rr}	Reverse Recovery Time	$V_R = 400\text{ V}, V_{GS} = 0\text{ V},$ $I_S = 30\text{ A}, dI_F / dt = 300\text{ A}/\mu\text{s}$	--	58	--	ns
Q_{rr}	Reverse Recovery Charge		--	122	--	nC
I_{rrm}	Peak Reverse Recovery Current		--	3.75	--	A

Typical Characteristics

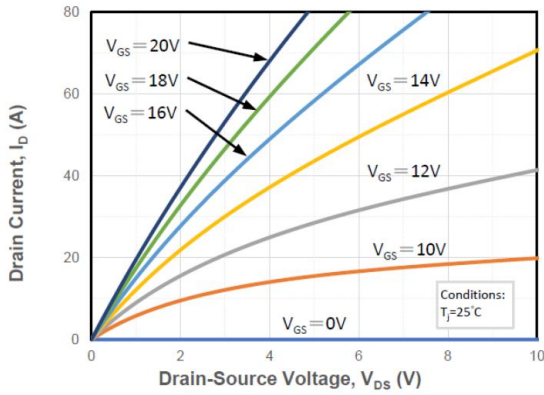


Figure 1. Output Characteristics $T_J=25^\circ\text{C}$

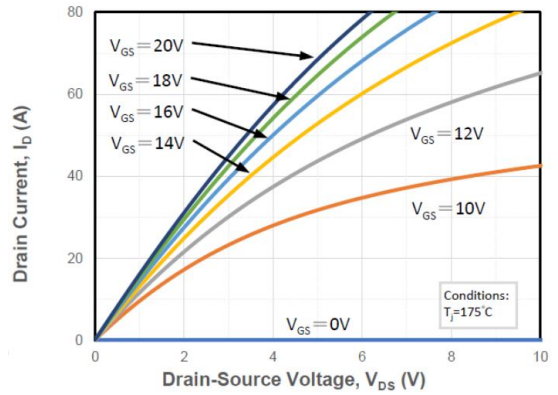


Figure 2. Output Characteristics $T_J=175^\circ\text{C}$

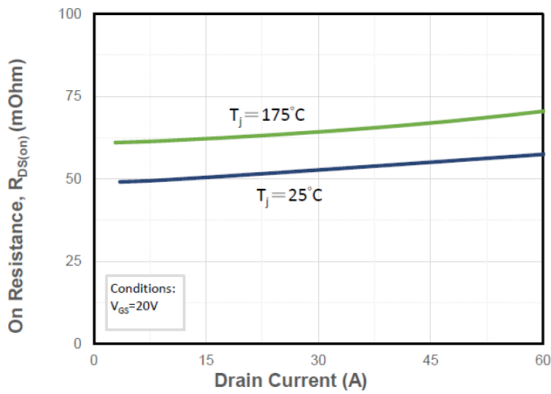


Figure 3. On-resistance vs. Drain Current

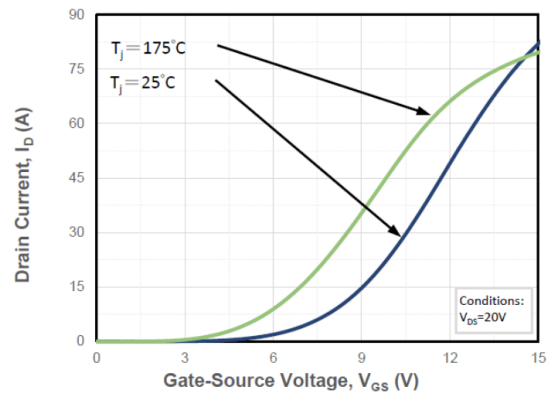


Figure 4. Transfer Characteristics for various T_J

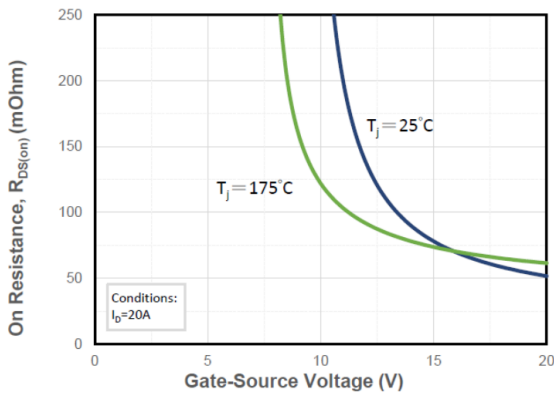


Figure 5. On-resistance vs. gate voltage for various T_J

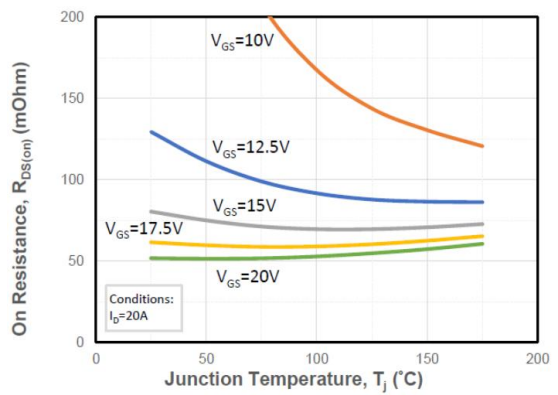


Figure 6. On-resistance vs. Temperature for various Gate Voltage

Typical Characteristics

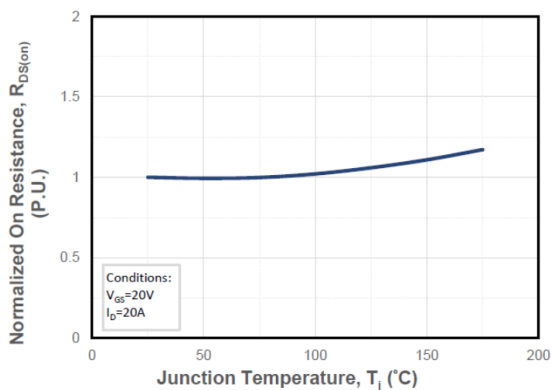


Figure 7. Normalized On-resistance vs. Temperature

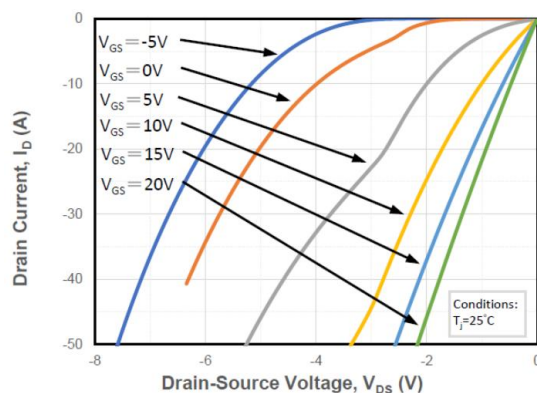


Figure 8. Reverse output characteristics at $T_J=25^\circ\text{C}$

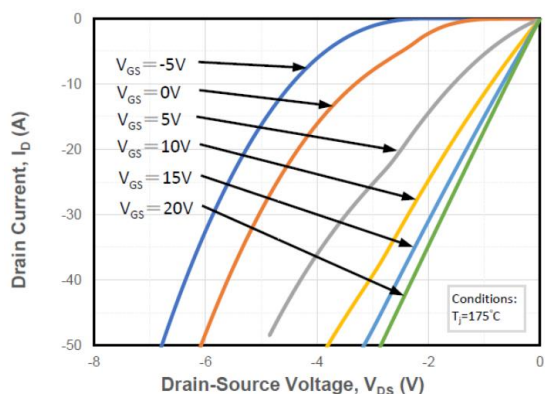


Figure 9. Reverse output characteristics at $T_J=175^\circ\text{C}$

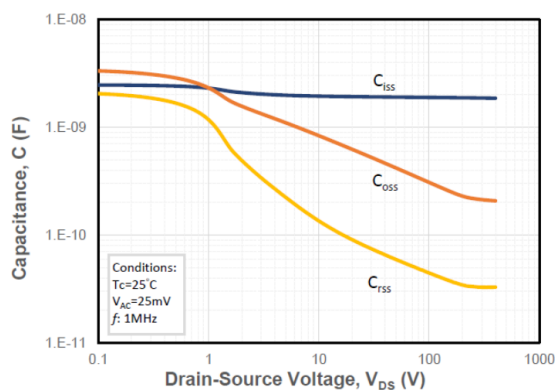


Figure 10. Capacitance vs. Drain to Source Voltage

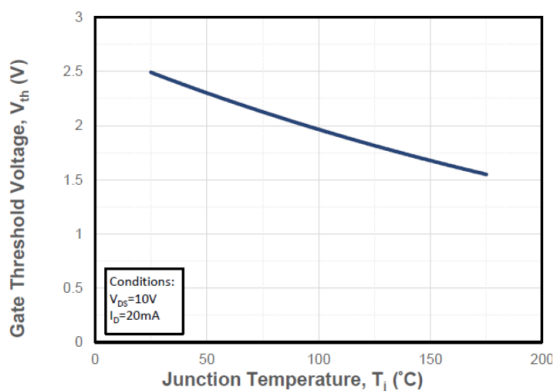


Figure 11. Threshold Voltage vs. Temperature

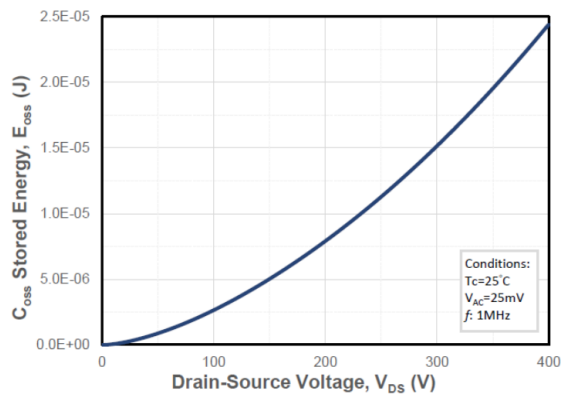


Figure 12. Output capacitor stored energy

Typical Characteristics

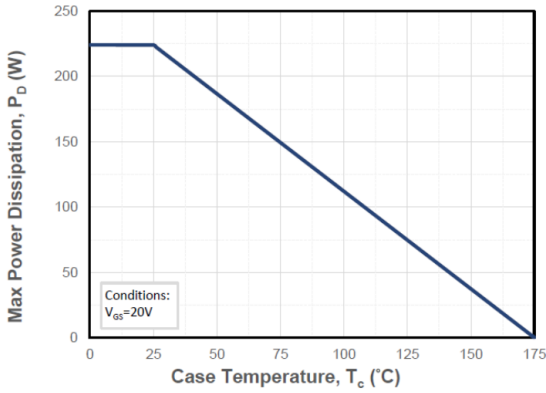


Figure 13. Maximum Power dissipation derating vs. Case temperature

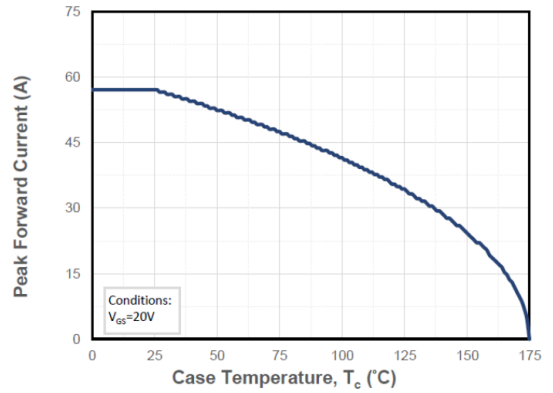


Figure 14. Drain current derating vs. case temperature

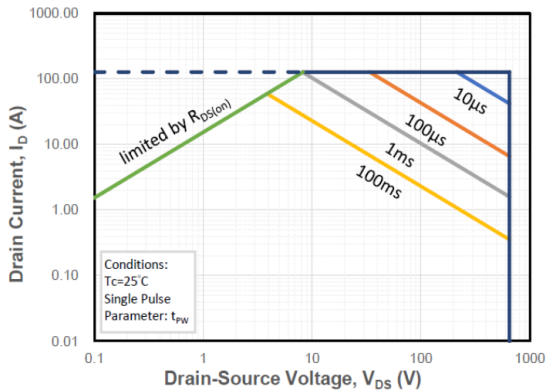


Figure 15. Safe Operating Area

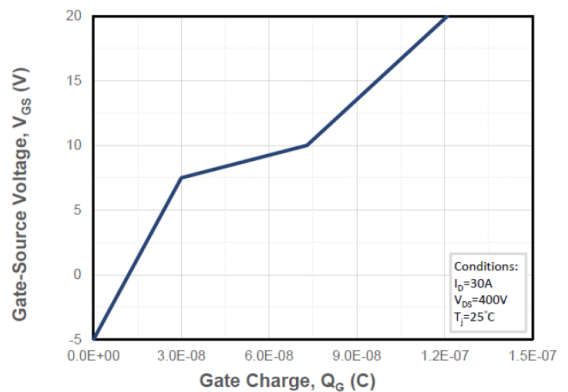


Figure 16. Gate charge characteristics

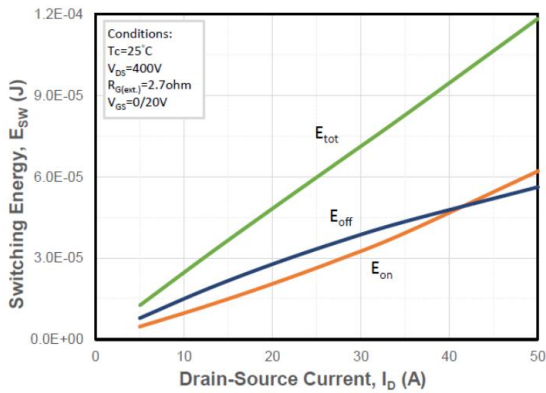


Figure 17. Clamped inductive switching energy vs. Drain current

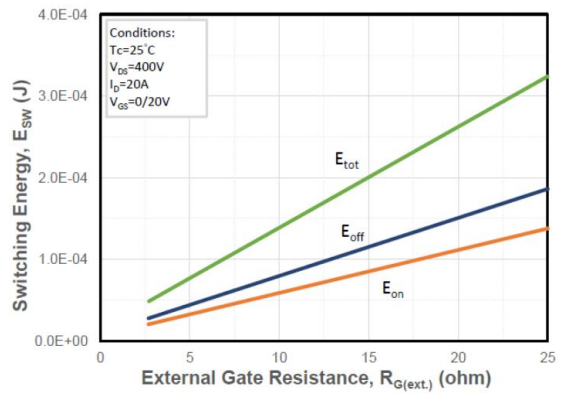


Figure 18. Clamped inductive switching energy vs. External gate resistor ($R_{G(ext.)}$)

Typical Characteristics

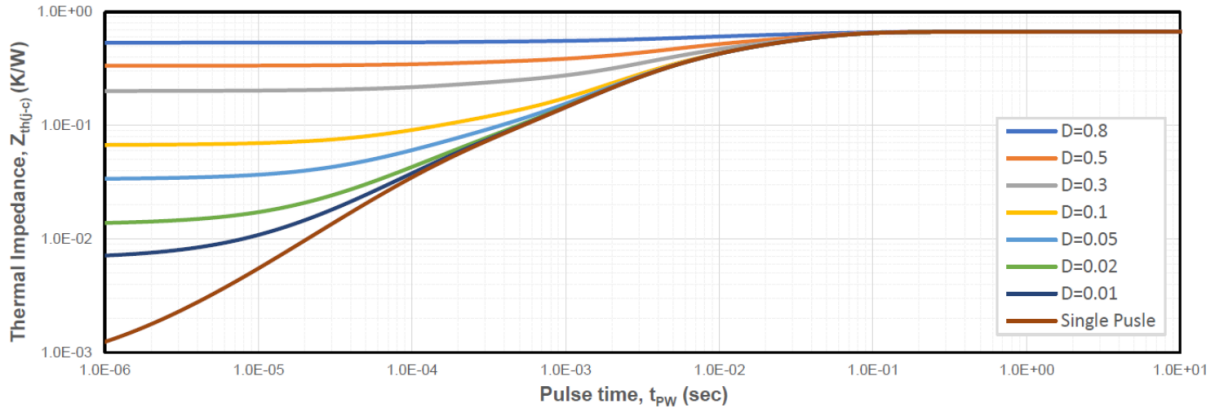
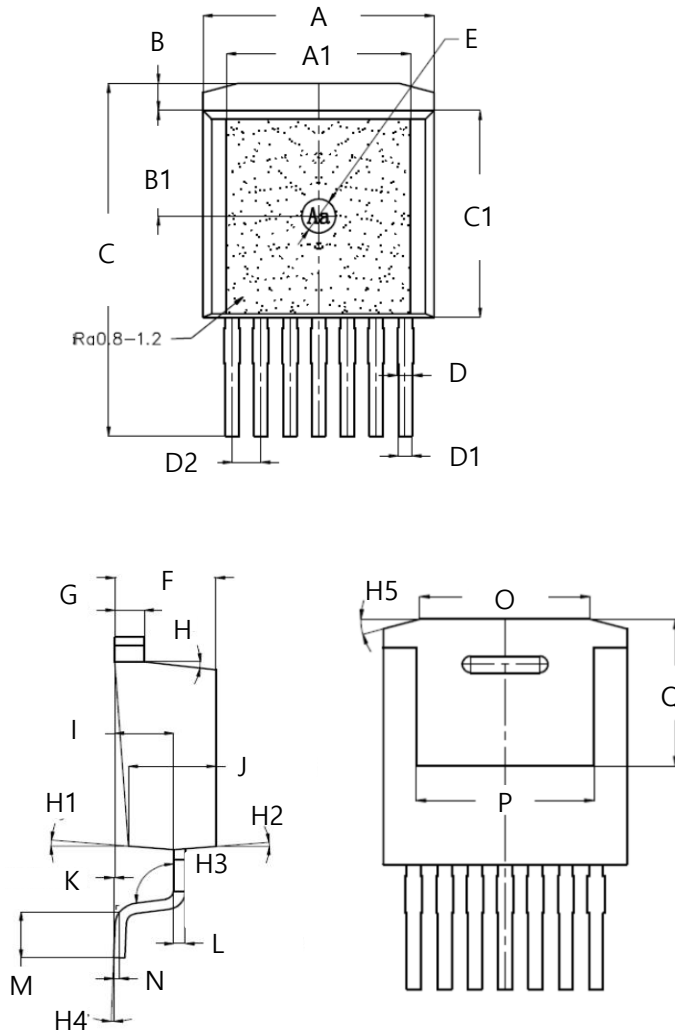


Figure 19. Transient Junction to Case Thermal Impedance

Package Outline

Unit : mm



SYMBOL	DIMENSIONS		
	MIN	NOM	MAX
A	10.08	10.18	10.28
A1	8.08	8.10	8.12
B	1.10	1.20	1.3
B1	4.53	4.63	4.73
C	15.30	15.50	15.70
C1	8.98	9.08	9.18
D	0.60	0.70	0.80
D1	0.59	0.60	0.61
D2	-	1.27	-
E	0.05	0.10	0.15
F	4.40	4.45	4.50
G	1.29	1.30	1.31
H	-	7°	-
H1	-	5°	-
H2	-	5°	-
H3	93°	98°	103°
H4	0°	-	5°
H5	-	15°	-
I	2.55	2.60	2.65
J	4.35	4.40	4.45
K	0	0.05	0.10
L	0.49	0.50	0.51
M	2.0	2.2	2.4
N	-	0.25	-
O	6.92	7.12	7.32
P	-	7.45	-
Q	-	6.15	-